

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10663714	INOUE ET AL.
Examiner	Art Unit	
Ahmed Sefer	2826	

SEARCHED

Class	Subclass	Date	Examiner
257	103,744,745,98	6/12/08	A.S.
438	25,27	6/12/08	A.S.

SEARCH NOTES

Search Notes	Date	Examiner
EAST (USPAT, US-PG-Pub, Derwent, EPO & JPO)	6/12/08	A.S.
257/E33.005 257/E33.028 257/E33.064	6/12/08	A.S.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
257	98,103,744,745	6/12/08	A.S.